Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/611,866	SEKIYA, CHIKAKO	
Examiner	Art Unit	
Michelle Crowell	1763	

Michelle Crowell

SEARCHED				
Class	Subclass	Date	Examiner	
118	723e	6/24/2005	AMC	
118	- 712	·		
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH (INCLUDING SEAR		)
	DATE	EXMR
see EAST text search	6/24/2005	AMC
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